


<b>Search Notes</b>  	<b>Application/Control No.</b>  10560447	<b>Applicant(s)/Patent Under Reexamination</b>  HESEN ET AL.
	<b>Examiner</b>  Chhaya, Swapneel	<b>Art Unit</b>  2822

SEARCHED			
Class	Subclass	Date	Examiner
257	667-677	7/18/2007	Swapneel Chhaya
438	110-114, 123	7/18/2007	Swapneel Chhaya

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted Kiesha Rose	7/18/2007	Swapneel Chhaya

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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